

Notice of References Cited	Application/Control No. 10/729,987	Applicant(s)/Patent Under Reexamination YOON ET AL	
	Examiner John B. Walsh	Art Unit 2151	Page 1 of 1

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*	C	US-7,082,353	07-2006	Kwon et al.	700/277
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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